

# CDCV304-EP

SCAS927A - MARCH 2012

# 200-MHz GENERAL-PURPOSE CLOCK BUFFER, PCI-X COMPLIANT

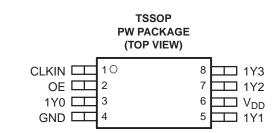
Check for Samples: CDCV304-EP

#### FEATURES

- General-Purpose and PCI-X 1:4 Clock Buffer
- Operating Frequency
  - 0 MHz to 200 MHz General-Purpose
- Low Output Skew: <100 ps
- Distributes One Clock Input to One Bank of Four Outputs
- Output Enable Control that Drives Outputs Low when OE is Low
- Operates from Single 3.3-V Supply or 2.5-V
  Supply
- PCI-X Compliant
- 8-Pin TSSOP Package

# SUPPORTS DEFENSE, AEROSPACE, AND MEDICAL APPLICATIONS

- Controlled Baseline
- One Assembly/Test Site
- One Fabrication Site
- Available in -40°C/105°C Temperature Range<sup>(1)</sup>
- Extended Product Life Cycle
- Extended Product-Change Notification
- Product Traceability



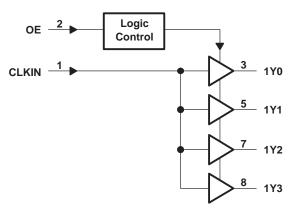
(1) Custom temperature ranges available

## DESCRIPTION

The CDCV304 is a high-performance, low-skew, general-purpose PCI-X compliant clock buffer. It distributes one input clock signal (CLKIN) to the output clocks (1Y[0:3]). It is specifically designed for use with PCI-X applications. The CDCV304 operates at 3.3 V and 2.5 V and is therefore compliant to the 3.3-V PCI-X specifications.

The CDCV304 is characterized for operation from -40°C to 105°C.

#### FUNCTIONAL BLOCK DIAGRAM



#### **Table 1. FUNCTION TABLE**

INPUTS		OUTPUTS
CLKIN	OE	1Y[0:3]
L	L	L
Н	L	L
L	Н	L
Н	Н	Н



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### Table 2. ORDERING INFORMATION<sup>(1)</sup>

T <sub>A</sub>	PACKAGE	ORDERABLE PART NUMBER	TOP-SIDE MARKING	VID NUMBER
-40°C to 105°C	TSSOP - PW	CDCV304TPWREP	C304T	V62/12618-01XE

 For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at www.ti.com.

#### **TERMINAL FUNCTIONS**

	TERMINAL	I/O	DESCRIPTION		
NAME	NO.	1/0	DESCRIPTION		
1Y[0:3]	3, 5, 7, 8	0	Buffered output clocks		
CLKIN	1	Ι	Input reference frequency		
GND	4	Power	Ground		
OE	2	Ι	Output enable control		
V <sub>DD</sub>	6	Power	Supply		

#### **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

	UNIT
Supply voltage range, V <sub>DD</sub>	–0.5 V to 4.3 V
Input voltage range, V <sub>I</sub> <sup>(2) (3)</sup>	–0.5 V to V <sub>DD</sub> + 0.5 V
Output voltage range, $V_0^{(2)(3)}$	–0.5 V to V <sub>DD</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>DD</sub> )	±50 mA
Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>DD</sub> )	±50 mA
Continuous total output current, $I_O (V_O = 0 \text{ to } V_{DD})$	±50 mA
Storage temperature range T <sub>stg</sub>	–65°C to 150°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) This value is limited to 4.6 V maximum.

		CDCV304	
	THERMAL METRIC <sup>(1)</sup>		UNITS
		8 PINS	
θ <sub>JA</sub>	Junction-to-ambient thermal resistance <sup>(2)</sup>	175.8	
θ <sub>JCtop</sub>	Junction-to-case (top) thermal resistance <sup>(3)</sup>	61.8	
θ <sub>JB</sub>	Junction-to-board thermal resistance <sup>(4)</sup>	104.3	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter <sup>(5)</sup>	7.7	
Ψ <sub>JB</sub>	Junction-to-board characterization parameter <sup>(6)</sup>	102.6	

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.
- (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- (3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDECstandard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- (4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.
- (5) The junction-to-top characterization parameter,  $\psi_{JT}$ , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).
- (6) The junction-to-board characterization parameter,  $\psi_{JB}$ , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).

#### **RECOMMENDED OPERATING CONDITIONS**

		MIN	NOM	MAX	UNIT
Supply voltage, V <sub>DD</sub>		2.3		3.6	V
Low-level input voltage, V <sub>IL</sub>				$0.3  ext{ x V}_{ ext{DD}}$	V
High-level input voltage, V <sub>IH</sub>		0.7 x V <sub>DD</sub>			V
Input voltage, V <sub>I</sub>		0		$V_{DD}$	V
	V <sub>DD</sub> = 2.5 V			-12	~ ^
High-level output current, I <sub>OH</sub>	V <sub>DD</sub> = 3.3 V			-24	mA
Low-level output current, IOI	V <sub>DD</sub> = 2.5 V			12	m۸
Edw-level output current, IOL	V <sub>DD</sub> = 3.3 V			24	mA
Operating free-air temperature, T	A	-40		105	°C

#### TIMING REQUIREMENTS

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
f <sub>clk</sub>	Clock frequency		0		200	MHz

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#### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CC	TEST CONDITIONS		TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub> Input voltage		V <sub>DD</sub> = 3 V,	I <sub>I</sub> = -18 mA			-1.2	V
		V <sub>DD</sub> = min to max,	I <sub>OH</sub> = -1 mA	$V_{DD} - 0.3$			
\ <i>\</i>	OH High-level output voltage	V <sub>DD</sub> = 2.3 V,	$I_{OH} = -8 \text{ mA}$	1.78			V
VOH		V <sub>DD</sub> = 3 V,	I <sub>OH</sub> = -24 mA	1.90			V
		V <sub>DD</sub> = 3 V,	I <sub>OH</sub> = -12 mA	2.30			
		V <sub>DD</sub> = 2.3 V,	I <sub>OL</sub> = 8 mA			0.51	
v		V <sub>DD</sub> = min to max,	I <sub>OL</sub> = 1 mA			0.20	V
V <sub>OL</sub>	Low-level output voltage	$V_{DD} = 3 V,$	I <sub>OL</sub> = 24 mA			0.84	
		V <sub>DD</sub> = 3 V,	I <sub>OL</sub> = 12 mA			0.60	
	Lligh lovel output ourrest	V <sub>DD</sub> = 3 V,	$V_{O} = 1 V$	-45			A
I <sub>OH</sub>	High-level output current	V <sub>DD</sub> = 3.3 V,	V <sub>O</sub> = 1.65 V		-55		mA
		V <sub>DD</sub> = 3 V,	$V_0 = 2 V$	54			A
I <sub>OL</sub>	Low-level output current	V <sub>DD</sub> = 3.3 V,	V <sub>O</sub> = 1.65 V		70		mA
l <sub>l</sub>	Input current	$V_{I} = V_{O} \text{ or } V_{DD}$				±5	μA
		f = 67 MHz,	$V_{DD} = 2.7 V$			28	A
I <sub>DD</sub>	Dynamic current, see	f = 67 MHz,	V <sub>DD</sub> = 3.6 V			37	mA
CI	Input capacitance	V <sub>DD</sub> = 3.3 V,	$V_I = 0 V \text{ or } V_{DD}$		3		pF
Co	Output capacitance	V <sub>DD</sub> = 3.3 V,	$V_{I} = 0 V \text{ or } V_{DD}$		3.2		pF

(1) All typical values are with respect to nominal  $V_{DD}$  and  $T_A$  = 25°C.



#### SWITCHING CHARACTERISTICS

 $V_{DD} = 2.5 \text{ V} \pm 10\%$ , C<sub>I</sub> = 10 pF (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
t <sub>PLH</sub>	Low-to-high propagation delay	See Figure 1 and Figure 2	2	2.9	4.5	
t <sub>PHL</sub>	High-to-low propagation delay	See Figure 1 and Figure 2	2	3	4.5	ns
t <sub>sk(o)</sub>	Output skew <sup>(2)</sup>	See Figure 3		50	150	ps
t <sub>r</sub>	Output rise slew rate <sup>(3)</sup>		1	2.2	4	V/ns
t <sub>f</sub>	Output fall slew rate <sup>(3)</sup>		1	2.2	4	V/ns

 $\begin{array}{ll} \mbox{(1)} & \mbox{All typical values are with respect to nominal V_{DD}. \\ \mbox{(2)} & \mbox{The } t_{sk(o)} \mbox{ specification is only valid for equal loading of all outputs and } T_A = -40^\circ C \mbox{ to } 85^\circ C. \\ \mbox{(3)} & \mbox{This symbol is according to PCI-X terminology.} \end{array}$ 

#### SWITCHING CHARACTERISTICS

 $V_{DD}$  = 3.3 V ± 10%, C<sub>L</sub>= 10 pF (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT	
t <sub>PLH</sub>	Low-to-high propagation delay	See Figure 1 and Figure 2	1.8	2.4	3.8	2	
t <sub>PHL</sub>	High-to-low propagation delay	See Figure 1 and Figure 2	1.8	2.5	3.8	ns	
t <sub>sk(o)</sub>	Output skew <sup>(2)</sup>			50	100	ps	
		12 kHz to 5 MHz, $f_{out}$ = 30.72 MHz		63		fa	
t <sub>jitter</sub>	Additive phase jitter from input to output 1Y0	12 kHz to 20 MHz, f <sub>out</sub> = 125 MHz		56		fs rms	
t <sub>sk(p)</sub>	Pulse skew	$V_{IH} = V_{DD}, V_{IL} = 0 V$		180		ps	
t <sub>sk(pr)</sub>	Process skew			0.2		ns	
t <sub>sk(pp)</sub>	Part-to-part skew			0.25		ns	
	Cleak high time, and Figure 4	66 MHz	6			2	
t <sub>high</sub>	Clock high time, see Figure 4	140 MHz	2.2			ns	
	Clash law time, and Figure 4	66 MHz	6				
t <sub>low</sub>	Clock low time, see Figure 4	140 MHz	3			ns	
t <sub>r</sub>	Output rise slew rate <sup>(3)</sup>		1	2.7	4	V/ns	
t <sub>f</sub>	Output fall slew rate <sup>(3)</sup>		1	2.7	4	V/ns	

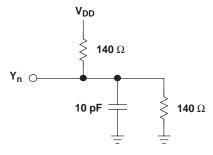
(1) All typical values are with respect to nominal V<sub>DD</sub>. (2) The t<sub>sk(o)</sub> specification is only valid for equal loading of all outputs and and  $T_A = -40^{\circ}$ C to 85°C. (3) This symbol is according to PCI-X terminology.

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#### PARAMETER MEASUREMENT INFORMATION





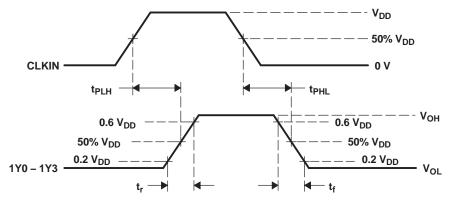
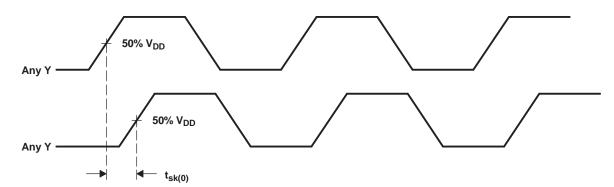
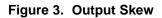


Figure 2. Voltage Waveforms Propagation Delay ( $t_{pd}$ ) Measurements





▶   /
≠↓
0.4 V <sub>DD</sub> ak (Minimum)
+

A. All parameters in Figure 4 are according to PCI-X 1.0 specifications.

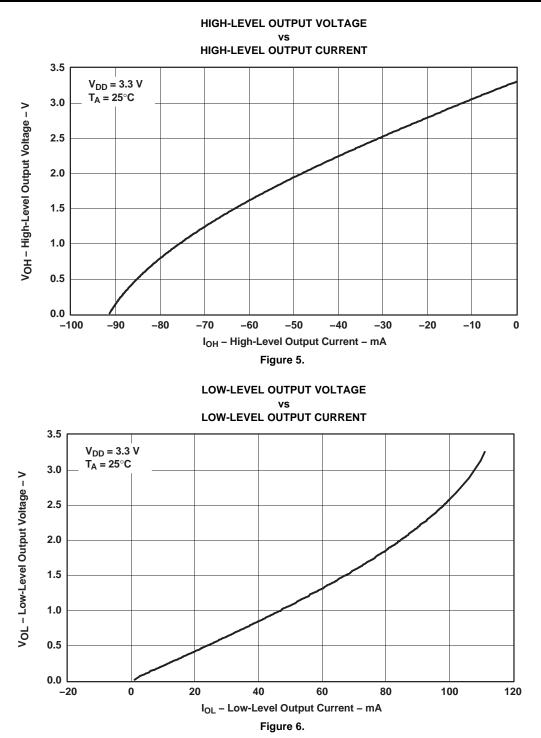
Figure 4. Clock Waveform

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11-Apr-2013

### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
CDCV304TPWREP	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 105	C304T	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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#### OTHER QUALIFIED VERSIONS OF CDCV304-EP :

Catalog: CDCV304



#### NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

# PACKAGE OPTION ADDENDUM

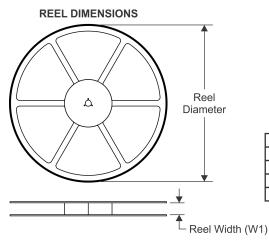
11-Apr-2013

# PACKAGE MATERIALS INFORMATION

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#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCV304TPWREP	TSSOP	PW	8	2000	330.0	12.4	7.0	3.6	1.6	8.0	12.0	Q1

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# PACKAGE MATERIALS INFORMATION

26-Jun-2013



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCV304TPWREP	TSSOP	PW	8	2000	367.0	367.0	35.0

PW (R-PDSO-G8)

PLASTIC SMALL OUTLINE



Α. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. Ŗ. This drawing is subject to change without notice.

🖄 Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



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